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TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSII)

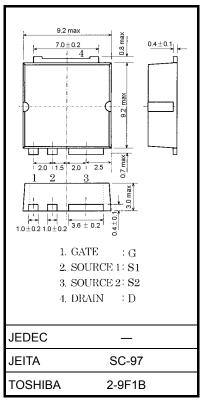
2SK3442

Switching Regulator, DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance: $RDS(ON) = 15 m\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 28 \text{ S} \text{ (typ.)}$
- Low leakage current: $I_{DSS} = 100 \ \mu A (V_{DS} = 100 \ V)$
- Enhancement mode: $V_{th} = 2.0 \sim 4.0 \text{ V} (V_{DS} = 10 \text{ V}, \text{ID} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Sheet4U.c@haracteristics		Symbol	Rating	Unit	
Drain-source voltage	Drain-source voltage		100	V	
Drain-gate voltage (RG	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		100	V	
Gate-source voltage	Gate-source voltage		±30	V	
Drain current	DC (Note 1)	ID	45	А	
Drain current	Pulse (Note 1)	I _{DP}	180	A	
Drain power dissipatior	Drain power dissipation $(Tc = 25^{\circ}C)$		125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	468	mJ	
Avalanche current		I _{AR}	45	А	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 0.74 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.00	°C/W

Notice:

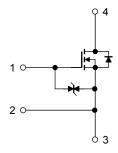
Please use the S1 pin for gate input signal return. Make sure that the main current flows into the S2 pin.

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2 $~V_{DD}$ = 25 V, T_{ch} = 25°C (initial), L = 373 $\mu H,~R_G$ = 25 $\Omega,~I_{AR}$ = 45 A

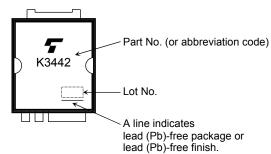
Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



Unit: mm

Marking



Electrical Characteristics (Note 4) (Ta = 25°C)

	Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
	Gate leakage current		I _{GSS}	$V_{GS} = \pm 25$ V, $V_{DS} = 0$ V	_	_	±10	μA
	Drain cut-off curr	ent	I _{DSS}	$V_{DS} = 100 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_		100	μA
www.Date	Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	100		_	V
	Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	2.0		4.0	V
	Drain-source ON	resistance	R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 23 \text{ A}$	_	15	20	mΩ
	Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 23 \text{ A}$	14	28	_	S
	Input capacitance Reverse transfer capacitance Output capacitance	C _{iss}		_	4100	_		
		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	340	_	pF	
		C _{oss}		_	980	_		
	Switching time Switching time Fall time Turn-off time Total gate charge (gate-source plus gate-drain)	Rise time	tr	$V_{GS}^{10 V}$		15		
		Turn-on time	t _{on}			45	_	
		Fall time	t _f			20	_	- ns
		Turn-off time	t _{off}	/// /// /// /////////////////////////		95	_	
		Qg		_	85	_	_	
	Gate-source charge Gate-drain ("miller") charge		Q _{gs}	$V_{DD} \simeq 80 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 45 \text{ A}$	_	50	_	nC
			Q _{gd}			35	_	

Note 4: Connect the S1 and S2 pins together, and ground them except during switching time measurement.

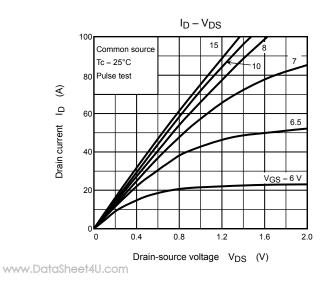
Source-Drain Ratings and Characteristics (Note 5) (Ta = 25°C)

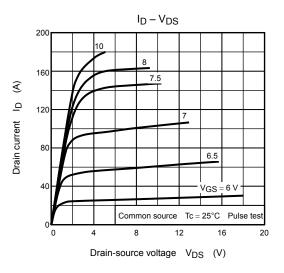
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 1	—	_	_	45	А
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 1	—			180	A
Continuous drain reverse current (Note 1, Note 5)	I _{DR} 2	—			1	А
Pulse drain reverse current (Note 1, Note 5)	I _{DRP} 2	—			4	A
Forward voltage (diode)	V _{DS2F}	I _{DR} = 45 A, V _{GS} = 0 V	_	_	-1.5	V
Reverse recovery time	t _{rr}	$I_{DR} = 45 \text{ A}, V_{GS} = 0 \text{ V},$	_	160		ns
Reverse recovery charge	Qrr	dI _{DR} /dt = 50 A/µs		512	—	nC

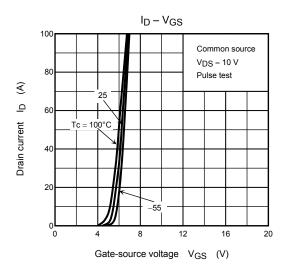
Note 5: I_{DR}1, I_{DRP}1: Current flowing between the drain and the S2 pin. Ensure that the S1 pin is left open. I_{DR}2, I_{DRP}2: Current flowing between the drain and the S1 pin. Ensure that the S2 pin is left open.

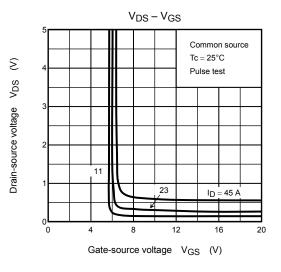
Unless otherwise specified, connect the S1 and S2 pins together, and ground them.

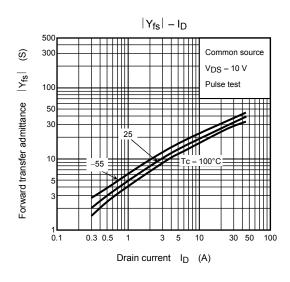
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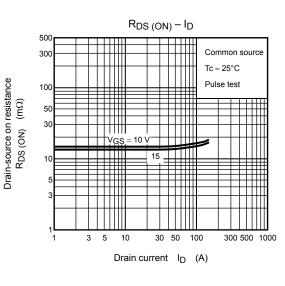




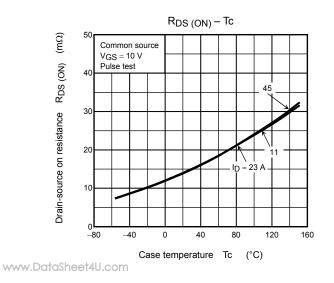


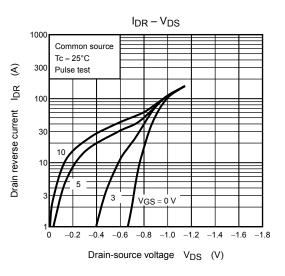




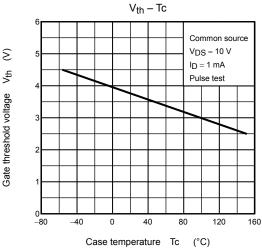


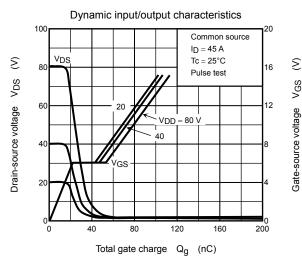
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Capacitance - V_{DS} 50000 ₩ 30000 10000 (PF) 5000 Capacitance C 3000 1000 500 Common source 300 VGS = 0 V f = 1 MHz $Tc = 25^{\circ}C$ 100**L** 0.1 0.3 0.5 30 50 3 100 1 5 10 Drain-source voltage V_{DS} (V)

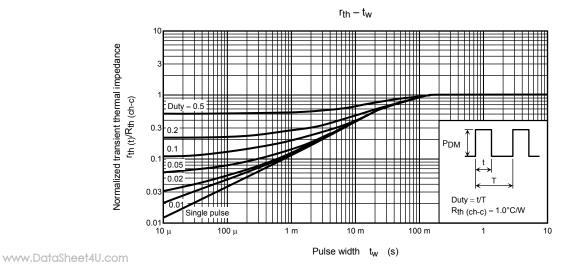




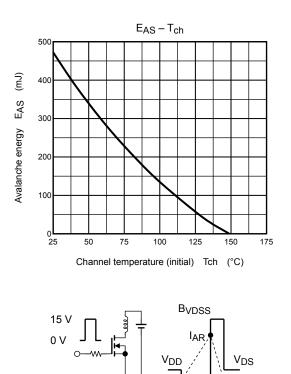
P_D – Tc 200 Ś 160 Drain power dissipation PD 120 80 40 10L 40 80 120 160 200 Case temperature Tc (°C)

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Safe operating area 1000 300 ID max (pulsed) * 100 μs * 100 ID max (continuous E 30 ₽ Drain current 10 DC operation Single nonrepetitive pulse $\text{Tc}=25^{\circ}\text{C}$ 0.3 Curves must be derated linearly with increase in temperature. VDSS max 0.1 3 10 30 100 300 1000 1 Drain-source voltage V_{DS} (V)



		,
$R_G = 25 \Omega$	$FAS = \frac{1}{1} \cdot L \cdot l^2$	$\left(\frac{BVDSS}{BVDSS}-VDD}\right)$
$V_{DD}=25~V,~L=373~\mu H$	2	BVDSS-VDD

Wave form

Test circuit

5

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